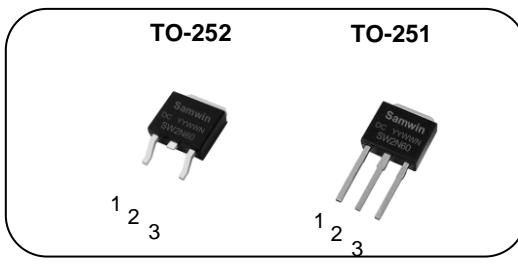
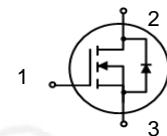


**N-channel Enhanced mode TO-252/TO-251 MOSFET****Features**

- High ruggedness
- Low  $R_{DS(ON)}$  (Typ 3.9Ω)@ $V_{GS}=10V$
- Low Gate Charge (Typ9.5nC)
- Improved dv/dt Capability
- 100% Avalanche Tested
- Application:Charger,Adaptor,LED

 **$BV_{DSS}$  :600V** **$I_D$  : 2A** **$R_{DS(ON)}$  : 3.9Ω****General Description**

This power MOSFET is produced with advanced technology of SAMWIN.

This technology enable the power MOSFET to have better characteristics, including fast switching time, low on resistance, low gate charge and especially excellent avalanche characteristics.

**Order Codes**

Item	Sales Type	Marking	Package	Packaging
1	SW D 2N60DC	SW2N60DC	TO-252	REEL
2	SW I 2N60DC	SW2N60DC	TO-251	TUBE

**Absolute maximum ratings**

Symbol	Parameter	Value		Unit
		TO-252	TO-251	
$V_{DSS}$	Drain to source voltage	600		V
$I_D$	Continuous drain current (@ $T_C=25^\circ C$ )	2*		A
	Continuous drain current (@ $T_C=100^\circ C$ )	1.26*		A
$I_{DM}$	Drain current pulsed (note 1)	8		A
$V_{GS}$	Gate to source voltage	$\pm 30$		V
$E_{AS}$	Single pulsed avalanche energy (note 2)	80		mJ
$E_{AR}$	Repetitive avalanche energy (note 1)	12		mJ
dv/dt	Peak diode recovery dv/dt (note 3)	5		V/ns
$P_D$	Total power dissipation (@ $T_C=25^\circ C$ )	78		W
	Derating factor above 25°C	0.6		W/ $^\circ C$
$T_{STG}, T_J$	Operating junction temperature & storage temperature	-55 ~ + 150		$^\circ C$
$T_L$	Maximum lead temperature for soldering purpose, 1/8 from case for 5 seconds.	300		$^\circ C$

\*. Drain current is limited by junction temperature.

**Thermal characteristics**

Symbol	Parameter	Value		Unit
		TO-252	TO-251	
$R_{thjc}$	Thermal resistance, Junction to case	1.6		$^\circ C/W$
$R_{thja}$	Thermal resistance, Junction to ambient		86.6	$^\circ C/W$

Electrical characteristic (  $T_C = 25^\circ\text{C}$  unless otherwise specified )

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
<b>Off characteristics</b>						
$\text{BV}_{\text{DSS}}$	Drain to source breakdown voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	600			V
$\Delta \text{BV}_{\text{DSS}} / \Delta T_J$	Breakdown voltage temperature coefficient	$I_{\text{D}}=250\mu\text{A}$ , referenced to $25^\circ\text{C}$		0.5		$^\circ\text{C}$
$I_{\text{DSS}}$	Drain to source leakage current	$V_{\text{DS}}=600\text{V}, V_{\text{GS}}=0\text{V}$		1		uA
		$V_{\text{DS}}=480\text{V}, T_C=125^\circ\text{C}$		50		uA
$I_{\text{GSS}}$	Gate to source leakage current, forward	$V_{\text{GS}}=30\text{V}, V_{\text{DS}}=0\text{V}$		100		nA
	Gate to source leakage current, reverse	$V_{\text{GS}}=-30\text{V}, V_{\text{DS}}=0\text{V}$		-100		nA
<b>On characteristics</b>						
$V_{\text{GS(TH)}}$	Gate threshold voltage	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	2.5		4.5	V
$R_{\text{DS(ON)}}$	Drain to source on state resistance	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=1\text{A}$		3.9	4.5	$\Omega$
$G_{\text{fs}}$	Forward transconductance	$V_{\text{DS}}=30\text{V}, I_{\text{D}}=1\text{A}$		1.6		S
<b>Dynamic characteristics</b>						
$C_{\text{iss}}$	Input capacitance	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=25\text{V}, f=1\text{MHz}$		305		pF
$C_{\text{oss}}$	Output capacitance			45		
$C_{\text{rss}}$	Reverse transfer capacitance			15		
$t_{\text{d(on)}}$	Turn on delay time	$V_{\text{DS}}=300\text{V}, I_{\text{D}}=2\text{A}, V_{\text{GS}}=10\text{V}, R_G=25\Omega$ (note 4,5)		6.5		ns
$t_r$	Rising time			20		
$t_{\text{d(off)}}$	Turn off delay time			19		
$t_f$	Fall time			21		
$Q_g$	Total gate charge	$V_{\text{DS}}=480\text{V}, V_{\text{GS}}=10\text{V}, I_{\text{D}}=2\text{A}$ (note 4,5)		9.5		nC
$Q_{\text{gs}}$	Gate-source charge			2.5		
$Q_{\text{gd}}$	Gate-drain charge			4		
$R_g$	Gate resistance	$V_{\text{DS}}=0\text{V}$ , Scan F mode		4.3		$\Omega$

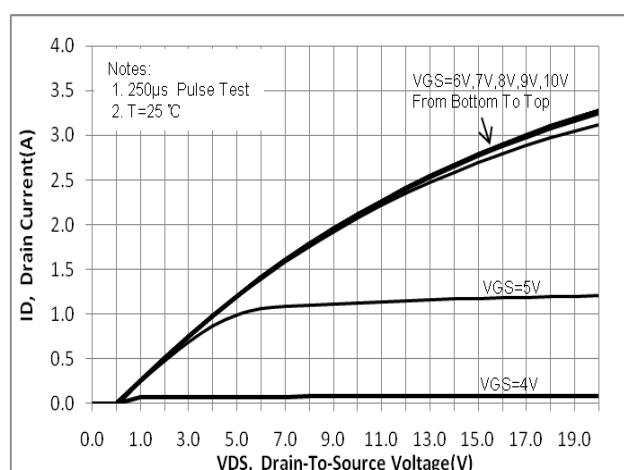
#### Source to drain diode ratings characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_s$	Continuous source current	Integral reverse p-n Junction diode in the MOSFET			2	A
$I_{\text{SM}}$	Pulsed source current				8	A
$V_{\text{SD}}$	Diode forward voltage drop.	$I_s=2\text{A}, V_{\text{GS}}=0\text{V}$			1.4	V
$t_{\text{rr}}$	Reverse recovery time	$I_s=2\text{A}, V_{\text{GS}}=0\text{V}, dI_F/dt=100\text{A}/\mu\text{s}$		250		ns
$Q_{\text{rr}}$	Reverse recovery charge			1.1		$\mu\text{C}$

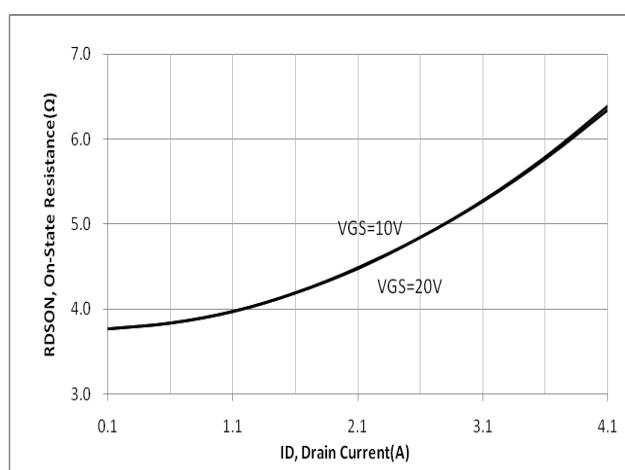
※. Notes

- Repetitive rating : pulse width limited by junction temperature.
- $L = 40\text{mH}, I_{\text{AS}} = 2\text{A}, V_{\text{DD}} = 50\text{V}, R_G = 25\Omega$ , Starting  $T_J = 25^\circ\text{C}$
- $I_{\text{SD}} \leq 2\text{A}, dI/dt = 100\text{A}/\mu\text{s}, V_{\text{DD}} \leq \text{BV}_{\text{DSS}}$ , Starting  $T_J = 25^\circ\text{C}$
- Pulse Test : Pulse Width  $\leq 300\text{us}$ , duty cycle  $\leq 2\%$ .
- Essentially independent of operating temperature.

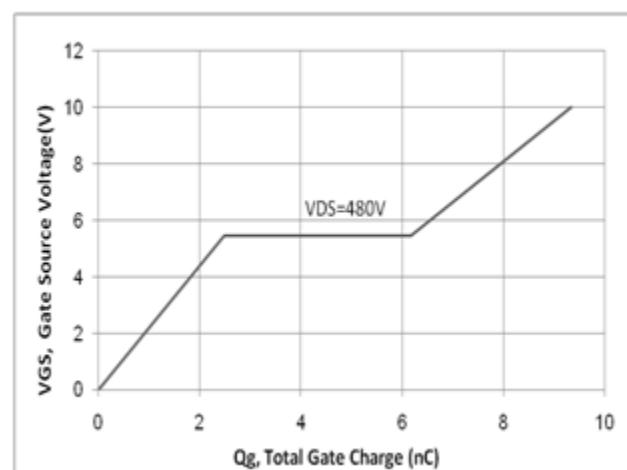
**Fig. 1. On-state characteristics**



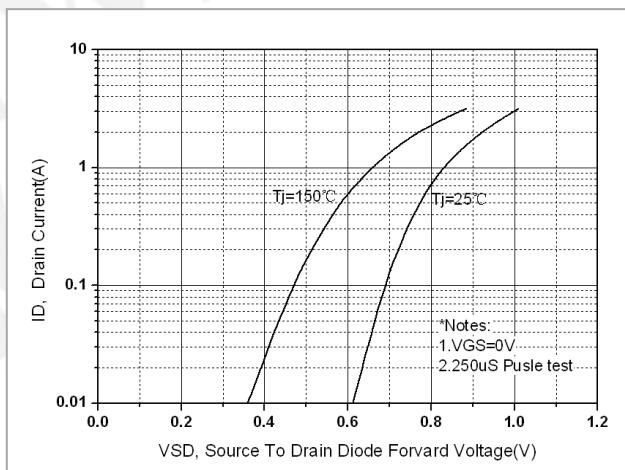
**Fig. 2. On-resistance variation vs. drain current and gate voltage**



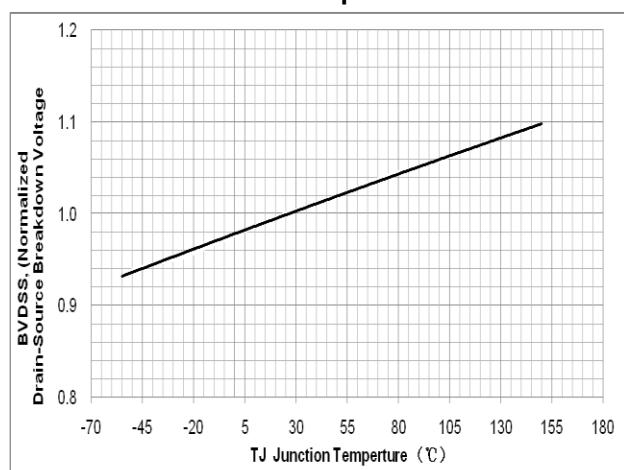
**Fig. 3. Gate charge characteristics**



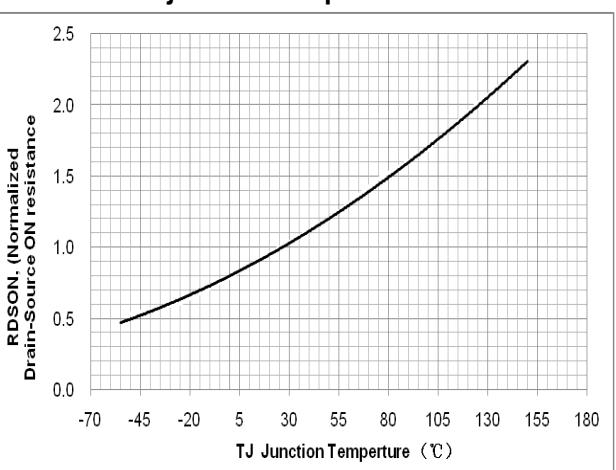
**Fig. 4. On state current vs. diode forward voltage**



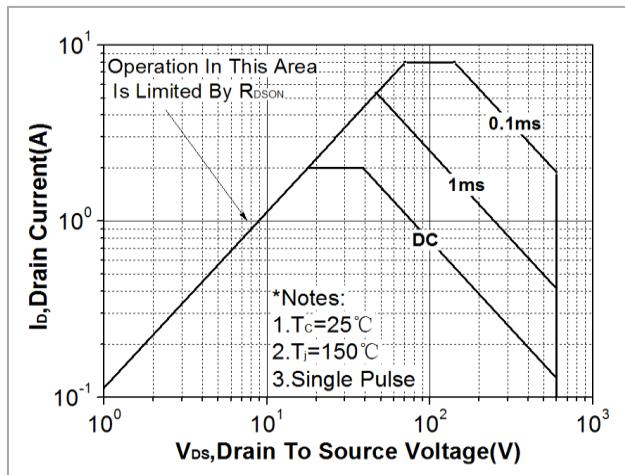
**Fig 5. Breakdown Voltage Variation vs. Junction Temperature**



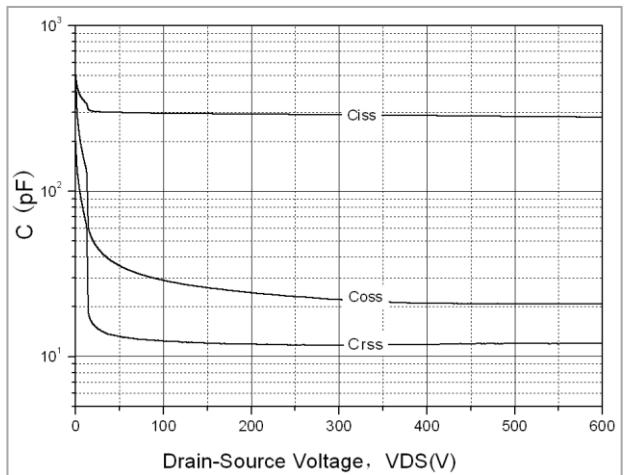
**Fig. 6. On resistance variation vs. junction temperature**



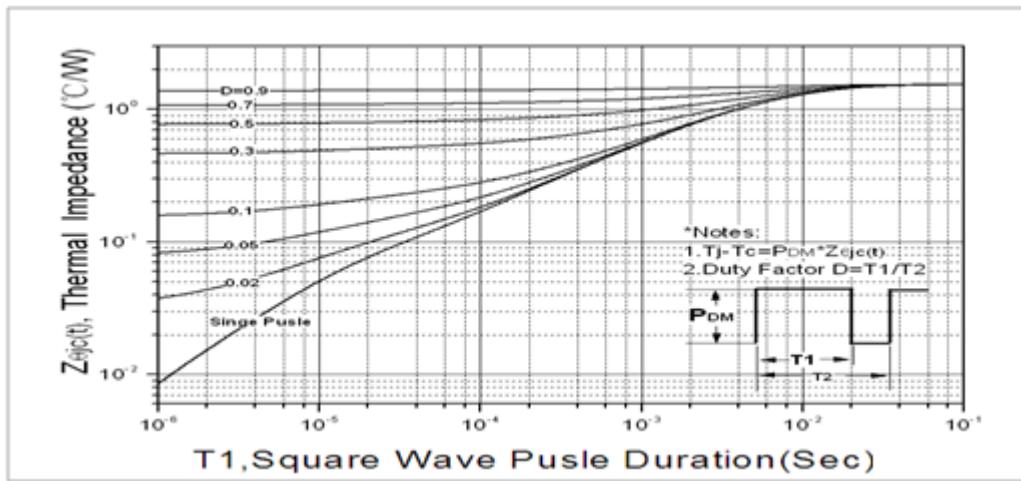
**Fig. 7. Maximum safe operating area (TO-252&TO-251)**



**Fig. 8. Capacitance Characteristics**



**Fig. 9. Transient thermal response curve(TO-252&TO-251)**



**Fig. 10. Gate charge test circuit & waveform**

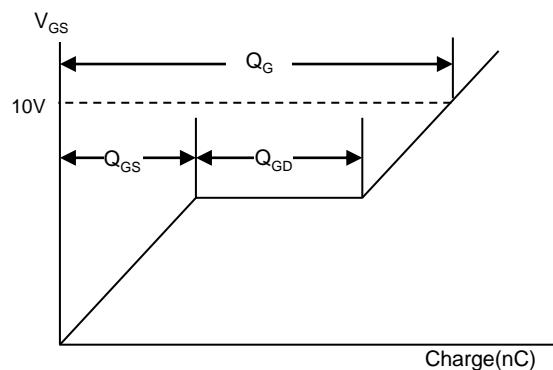
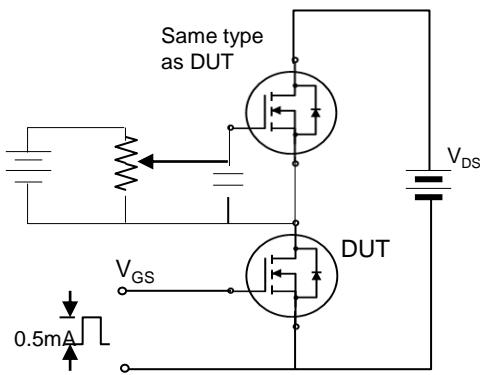


Fig. 11. Switching time test circuit & waveform

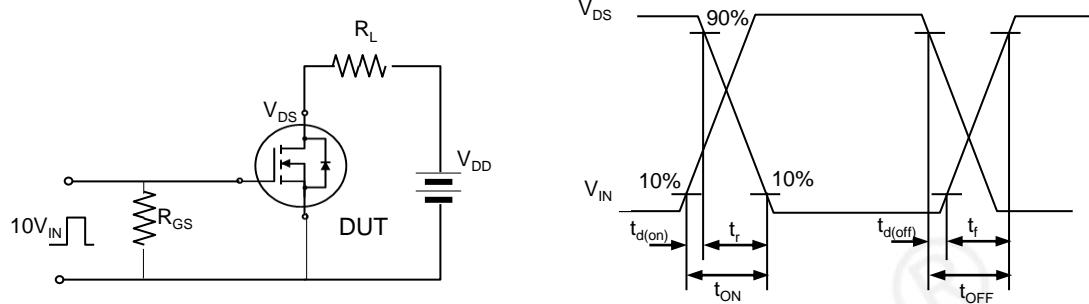


Fig. 12. Unclamped Inductive switching test circuit & waveform

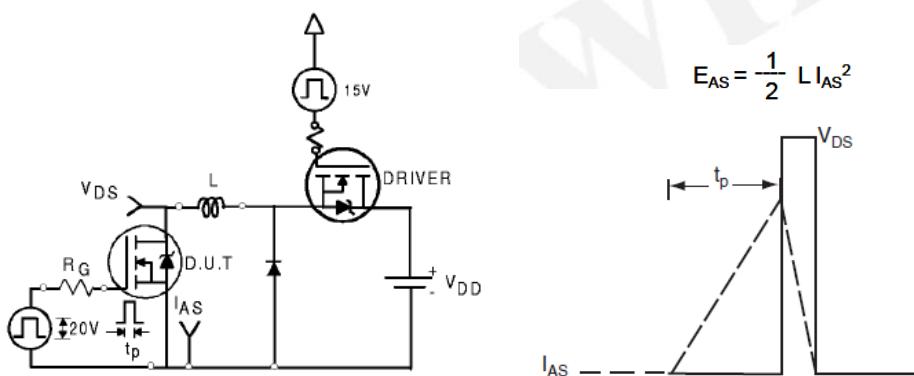
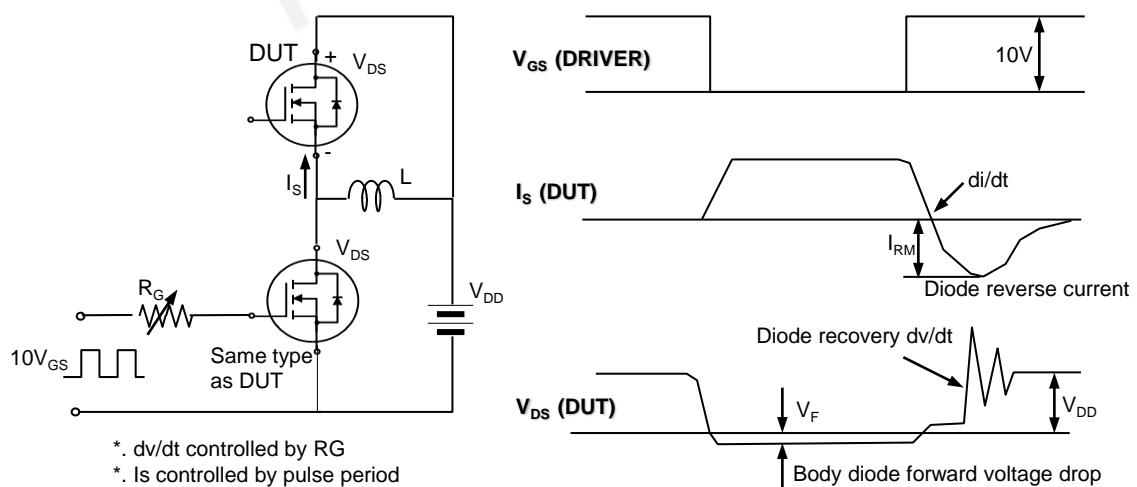


Fig. 13. Peak diode recovery dv/dt test circuit & waveform



Samwin®  
内部保密

### DISCLAIMER

- \* All the data&curve in this document was tested in SEMIPOWER TESTING & APPLICATION CENTER.
- \* This product has passed the PCT,TC,HTRB,HTGB,HAST,PC and Solderdunk reliability testing.
- \* Qualification standards can also be found on the Web site (<http://www.semipower.com.cn>) 
- \* Suggestions for improvement are appreciated, Please send your suggestions to [samwin@samwinsemi.com](mailto:samwin@samwinsemi.com)